Title (Units): COMP 7040 Computer Vision and Pattern Recognition (3,3,0)

Course Aims: To give students some advanced topics in the area of contemporary research of computer vision

and pattern recognition

Prerequisite: Research Postgraduate Student Standing

Course Intended Learning Outcomes (CILOs):

Upon successful completion of this course, students should be able to:

No.	Course Intended Learning Outcomes (CILOs)				
	Knowledge				
1	Explain basic theories and techniques of computer vision and pattern recognition				
2	Identify various approaches and design for computer vision and pattern recognition systems				
3	Discuss the advanced topics in computer vision and pattern recognition				
	Professional Skill				
4	Design and implement a simple computer vision and pattern recognition system which can handle certain problem				
5	Apply some new techniques to computer vision and pattern recognition				
	Attitude				
6	Appraise a variety of research issues in this field				

Calendar Description: This course gives students some advanced topics in the areas of computer vision and pattern recognition.

Teaching and Learning Activities (TLAs):

CILOs	TLAs
1-5	Students will learn all knowledge of computer vision and pattern recognition through lectures and tutorials.
1-3	Besides, assignment(s), and final examination will be designed to evaluate the students' learning performance.
	Students are required to read the research papers and write a term paper focusing on a specific topic in the fields
1-6	of computer vision and pattern recognition, whereby gaining an in-depth understanding of the latest status of the
	research development in these two fields.

Assessment:

No.	Assessment	Weighting	CILOs to	Remarks
	Methods		be	
			addressed	
1	Continuous Assessment	50%	1-6	Continuous assessments are designed to measure how well students have learned the fundamentals and major concepts of computer vision and pattern recognition. Some advanced topics are required to read and provide a term paper.
2	Final Examination	50%	1-6	Final examination questions are designed to see how far students have achieved their intended learning outcomes. Questions will primarily be analysis and skills based to assess students' knowledge in computer vision and pattern recognition as well as their applications.

Rubrics:

	Excellent (A)	Good (B)	Satisfactory (C)	Fail (F)
Creativity and	All of the concepts	Most of the	Some of the new	No new idea
originality on	and content are	concepts and	concepts	
group project	different from the	content are		
	lectures with	different from the		
	impressive	lectures with good		
	creativity	creativity		
	-	-		
Explain, analysis	Make good use of	Often make good	Sometimes make	Not able to make
and the use of	algorithms	use of algorithms	good use of	good use of
pattern			algorithms	algorithms
recognition				
algorithms				
Explain and	Well explain and	Explain and	Sometimes explain	Not able to explain
describe the	describe basic	describe basic	and describe basic	and describe basic

basic principle	principles of a	principles of a	principles of a	principles of a computer vision and pattern recognition system
of a pattern	computer vision	computer vision	computer vision	
recognition	and pattern	and pattern	and pattern	
system	recognition system	recognition system	recognition system	
Implementation of pattern recognition algorithm	Fully correct in implementing computer vision and pattern recognition algorithms	Mostly correct in implementing computer vision and pattern recognition algorithms	Partially correct in implementing computer vision and pattern recognition algorithms	Not able to implement computer vision and pattern recognition algorithms

Learning Outcomes and Weighting:

Content	CILO No.
I - V	1 - 5
VI	6

References:

C.H. Chen, <u>Handbook of Pattern Recognition & Computer Vision</u>, <u>5th Edition</u>, World Scientific, 2016

R. O. Duda, P. E. Hart and D. G. Stork, <u>Pattern Classification</u>, 2nd Edition, John Wiley & Sons, Inc, 2001.

Reinhard Klette, Concise Computer Vision: An Introduction into Theory and Algorithms, Springer, 2014.

IEEE Transactions on Pattern Analysis and Machine Intelligence

IEEE Transactions on Image Processing

IEEE Transactions on Circuit Systems and Video Technology

International Journal on Computer Vision

The Journal of the Pattern Recognition Society, Pattern Recognition.

Course Content in Outline:

Topic

- I. Image Formation
 - A. Photometric image formation
 - B. Geometric primitives and transformations
- II. Segmentation
 - A. Active contours
 - B. Split and merges
 - C. New techniques
- III. Feature Extraction
 - A. Bag of words
 - B. SIFT
 - C. New techniques
- IV Object Tracking
 - A. Point tracking
 - B. Kernel tracking
- V Classification Approaches
 - A. Statistical Method
 - B. Structural Method
 - C. Hybrid Method
- VI. Applications